

# BF1214

## Dual N-channel dual gate MOSFET

Rev. 01 — 30 October 2007

Product data sheet

## 1. Product profile

### 1.1 General description

The BF1214 is a combination of two dual gate MOSFET amplifiers with shared source and gate2 leads.

The source and substrate are interconnected. Internal bias circuits enable DC stabilization and a very good cross modulation performance during AGC. Integrated diodes between the gates and source protect against excessive input voltage surges. The transistor has a SOT363 micro-miniature plastic package.

#### CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Therefore care should be taken during transport and handling.

### 1.2 Features

- Two low noise gain controlled amplifiers in a single package; both with a partly integrated bias
- Superior cross modulation performance during AGC
- High forward transfer admittance
- High forward transfer admittance to input capacitance ratio
- Both amplifiers optimized for VHF applications, yet suitable for VHF and UHF applications

### 1.3 Applications

- Gain controlled low noise amplifiers for VHF and UHF applications with 5 V supply voltage
  - ◆ digital and analog television tuners
  - ◆ professional communication equipment

1.4 Quick reference data

Table 1. Quick reference data for amplifier A and B

| Symbol                | Parameter                    | Conditions                                                                               | Min | Typ | Max | Unit   |
|-----------------------|------------------------------|------------------------------------------------------------------------------------------|-----|-----|-----|--------|
| V <sub>DS</sub>       | drain-source voltage         | DC                                                                                       | -   | -   | 6   | V      |
| I <sub>D</sub>        | drain current                | DC                                                                                       | -   | -   | 30  | mA     |
| P <sub>tot</sub>      | total power dissipation      | T <sub>sp</sub> ≤ 107 °C                                                                 | [1] | -   | 180 | mW     |
| y <sub>fs</sub>       | forward transfer admittance  | f = 100 MHz; T <sub>j</sub> = 25 °C; I <sub>D</sub> = 18 mA                              | 27  | 32  | 37  | mS     |
| C <sub>iss</sub> (G1) | input capacitance at gate1   | f = 100 MHz                                                                              | [2] | -   | 2.2 | pF     |
| C <sub>rss</sub>      | reverse transfer capacitance | f = 100 MHz                                                                              | [2] | -   | 20  | fF     |
| NF                    | noise figure                 | f = 400 MHz; Y <sub>S</sub> = Y <sub>S(opt)</sub>                                        | -   | 0.9 | 1.5 | dB     |
|                       |                              | f = 800 MHz; Y <sub>S</sub> = Y <sub>S(opt)</sub>                                        | -   | 1.2 | 1.8 | dB     |
| Xmod                  | cross modulation             | input level for k = 1 % at 40 dB AGC; f <sub>w</sub> = 50 MHz; f <sub>unw</sub> = 60 MHz | [3] | 102 | 105 | - dBμV |
| T <sub>j</sub>        | junction temperature         |                                                                                          | -   | -   | 150 | °C     |

- [1] T<sub>sp</sub> is the temperature at the soldering point of the source lead.
- [2] Calculated from S-parameters.
- [3] Measured in [Figure 24](#) test circuit.

2. Pinning information

Table 2. Discrete pinning

| Pin | Description   | Simplified outline | Symbol |
|-----|---------------|--------------------|--------|
| 1   | drain (AMP A) |                    |        |
| 2   | source        |                    |        |
| 3   | drain (AMP B) |                    |        |
| 4   | gate1 (AMP B) |                    |        |
| 5   | gate2         |                    |        |
| 6   | gate1 (AMP A) |                    |        |

sym119

3. Ordering information

Table 3. Ordering information

| Type number | Package |                                          |         |
|-------------|---------|------------------------------------------|---------|
|             | Name    | Description                              | Version |
| BF1214      | -       | plastic surface-mounted package; 6 leads | SOT363  |

4. Marking

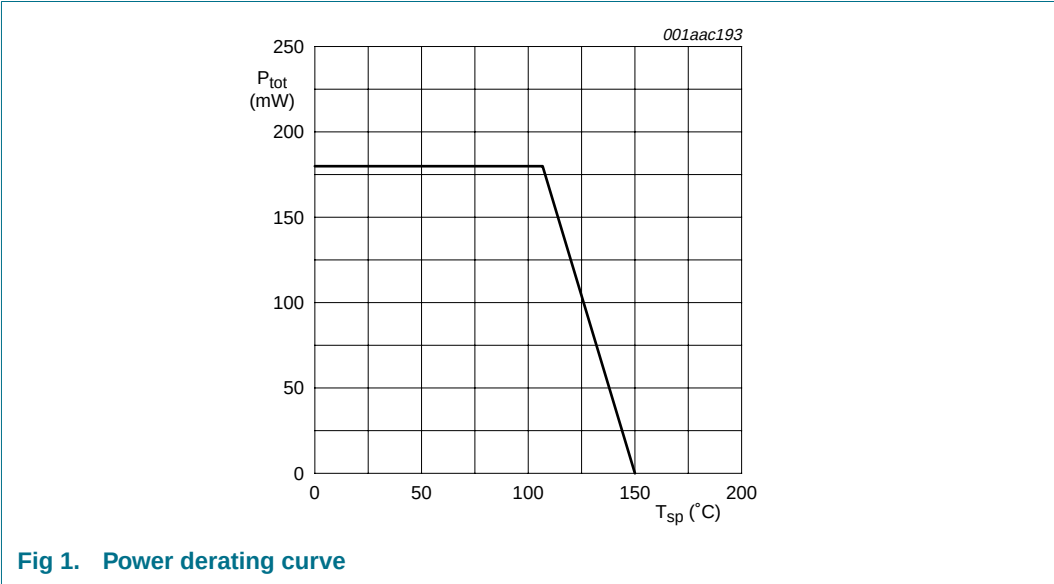
| Table 4. Marking |         |                           |
|------------------|---------|---------------------------|
| Type number      | Marking | Description               |
| BF1214           | SB*     | * = p : made in Hong Kong |
|                  |         | * = t : made in Malaysia  |
|                  |         | * = w : made in China     |

5. Limiting values

Table 5. Limiting values  
In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol           | Parameter               | Conditions                   | Min | Max  | Unit |
|------------------|-------------------------|------------------------------|-----|------|------|
| Per MOSFET       |                         |                              |     |      |      |
| V <sub>DS</sub>  | drain-source voltage    | DC                           | -   | 6    | V    |
| I <sub>D</sub>   | drain current           | DC                           | -   | 30   | mA   |
| I <sub>G1</sub>  | gate1 current           |                              | -   | ±10  | mA   |
| I <sub>G2</sub>  | gate2 current           |                              | -   | ±10  | mA   |
| P <sub>tot</sub> | total power dissipation | T <sub>sp</sub> ≤ 107 °C [1] | -   | 180  | mW   |
| T <sub>stg</sub> | storage temperature     |                              | -65 | +150 | °C   |
| T <sub>j</sub>   | junction temperature    |                              | -   | 150  | °C   |

[1] T<sub>sp</sub> is the temperature at the soldering point of the source lead.



## 6. Thermal characteristics

Table 6. Thermal characteristics

| Symbol         | Parameter                                        | Conditions | Typ | Unit |
|----------------|--------------------------------------------------|------------|-----|------|
| $R_{th(j-sp)}$ | thermal resistance from junction to solder point |            | 240 | K/W  |

## 7. Static characteristics

Table 7. Static characteristics

$T_j = 25\text{ }^{\circ}\text{C}$ .

| Symbol                                        | Parameter                      | Conditions                                                                                                   | Min                 | Typ | Max | Unit |
|-----------------------------------------------|--------------------------------|--------------------------------------------------------------------------------------------------------------|---------------------|-----|-----|------|
| <b>Per MOSFET; unless otherwise specified</b> |                                |                                                                                                              |                     |     |     |      |
| $V_{(BR)DSS}$                                 | drain-source breakdown voltage | $V_{G1-S} = V_{G2-S} = 0\text{ V}$ ; $I_D = 10\text{ }\mu\text{A}$                                           |                     |     |     |      |
|                                               |                                | amplifier A                                                                                                  | 6                   | -   | -   | V    |
|                                               |                                | amplifier B                                                                                                  | 6                   | -   | -   | V    |
| $V_{(BR)G1-SS}$                               | gate1-source breakdown voltage | $V_{G2-S} = V_{DS} = 0\text{ V}$ ; $I_{G1-S} = 10\text{ mA}$                                                 | 6                   | -   | 10  | V    |
| $V_{(BR)G2-SS}$                               | gate2-source breakdown voltage | $V_{G1-S} = V_{DS} = 0\text{ V}$ ; $I_{G2-S} = 10\text{ mA}$                                                 | 6                   | -   | 10  | V    |
| $V_{F(S-G1)}$                                 | forward source-gate1 voltage   | $V_{G2-S} = V_{DS} = 0\text{ V}$ ; $I_{S-G1} = 10\text{ mA}$                                                 | 0.5                 | -   | 1.5 | V    |
| $V_{F(S-G2)}$                                 | forward source-gate2 voltage   | $V_{G1-S} = V_{DS} = 0\text{ V}$ ; $I_{S-G2} = 10\text{ mA}$                                                 | 0.5                 | -   | 1.5 | V    |
| $V_{G1-S(th)}$                                | gate1-source threshold voltage | $V_{DS} = 5\text{ V}$ ; $V_{G2-S} = 4\text{ V}$ ; $I_D = 100\text{ }\mu\text{A}$                             | 0.3                 | -   | 1.0 | V    |
| $V_{G2-S(th)}$                                | gate2-source threshold voltage | $V_{DS} = 5\text{ V}$ ; $V_{G1-S} = 5\text{ V}$ ; $I_D = 100\text{ }\mu\text{A}$                             | 0.4                 | -   | 1.0 | V    |
| $I_{DS}$                                      | drain-source current           | $V_{G2-S} = 4\text{ V}$                                                                                      | <a href="#">[1]</a> |     |     |      |
|                                               |                                | amplifier A; $V_{DS(A)} = 5\text{ V}$ ; $R_{G1(A)} = 68\text{ k}\Omega$                                      | 13                  | -   | 23  | mA   |
|                                               |                                | amplifier B; $V_{DS(B)} = 5\text{ V}$ ; $R_{G1(B)} = 68\text{ k}\Omega$                                      | 13                  | -   | 23  | mA   |
| $I_{G1-S}$                                    | gate1 cut-off current          | $V_{G2-S} = 0\text{ V}$ ; $V_{DS(A)} = V_{DS(B)} = 0\text{ V}$                                               |                     |     |     |      |
|                                               |                                | amplifier A; $V_{G1-S(A)} = 5\text{ V}$                                                                      | -                   | -   | 50  | nA   |
|                                               |                                | amplifier B; $V_{G1-S(B)} = 5\text{ V}$                                                                      | -                   | -   | 50  | nA   |
| $I_{G2-S}$                                    | gate2 cut-off current          | $V_{G2-S} = 4\text{ V}$ ; $V_{DS(A)} = V_{DS(B)} = 0\text{ V}$ ;<br>$V_{G1-S(A)} = V_{G1-S(B)} = 0\text{ V}$ | -                   | -   | 20  | nA   |

[1]  $R_{G1}$  connects gate1 to  $V_{GG} = 5\text{ V}$ .

## 8. Dynamic characteristics

**Table 8. Dynamic characteristics for amplifier A and B**

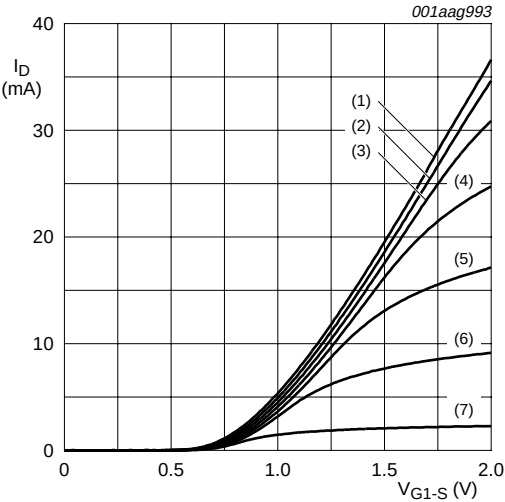
Common source;  $T_{amb} = 25\text{ }^{\circ}\text{C}$ ;  $V_{G2-S} = 4\text{ V}$ ;  $V_{DS} = 5\text{ V}$ ;  $I_D = 18\text{ mA}$ .

| Symbol        | Parameter                    | Conditions                                                                    | Min   | Typ | Max | Unit       |
|---------------|------------------------------|-------------------------------------------------------------------------------|-------|-----|-----|------------|
| $ y_{fs} $    | forward transfer admittance  | $f = 100\text{ MHz}$ ; $T_j = 25\text{ }^{\circ}\text{C}$                     | 27    | 32  | 37  | mS         |
| $C_{iss(G1)}$ | input capacitance at gate1   | $f = 100\text{ MHz}$                                                          | [1] - | 2.2 | 2.7 | pF         |
| $C_{iss(G2)}$ | input capacitance at gate2   | $f = 100\text{ MHz}$                                                          | [1] - | 3.5 | -   | pF         |
| $C_{oss}$     | output capacitance           | $f = 100\text{ MHz}$                                                          | [1] - | 0.8 | -   | pF         |
| $C_{rss}$     | reverse transfer capacitance | $f = 100\text{ MHz}$                                                          | [1] - | 20  | -   | fF         |
| $G_{tr}$      | transducer power gain        | amplifier A; $B_S = B_{S(opt)}$ ; $B_L = B_{L(opt)}$                          | [1]   |     |     |            |
|               |                              | $f = 200\text{ MHz}$ ; $G_S = 2\text{ mS}$ ; $G_L = 0.5\text{ mS}$            | 31    | 35  | 39  | dB         |
|               |                              | $f = 400\text{ MHz}$ ; $G_S = 2\text{ mS}$ ; $G_L = 1\text{ mS}$              | 27    | 31  | 35  | dB         |
|               |                              | $f = 800\text{ MHz}$ ; $G_S = 3.3\text{ mS}$ ; $G_L = 1\text{ mS}$            | 22    | 26  | 30  | dB         |
|               |                              | amplifier B; $B_S = B_{S(opt)}$ ; $B_L = B_{L(opt)}$                          | [1]   |     |     |            |
|               |                              | $f = 200\text{ MHz}$ ; $G_S = 2\text{ mS}$ ; $G_L = 0.5\text{ mS}$            | 31    | 35  | 39  | dB         |
|               |                              | $f = 400\text{ MHz}$ ; $G_S = 2\text{ mS}$ ; $G_L = 1\text{ mS}$              | 29    | 33  | 37  | dB         |
|               |                              | $f = 800\text{ MHz}$ ; $G_S = 3.3\text{ mS}$ ; $G_L = 1\text{ mS}$            | 25    | 29  | 33  | dB         |
| NF            | noise figure                 | $f = 11\text{ MHz}$ ; $G_S = 20\text{ mS}$ ; $B_S = 0\text{ S}$               | -     | 3.0 | -   | dB         |
|               |                              | $f = 400\text{ MHz}$ ; $Y_S = Y_{S(opt)}$                                     | -     | 0.9 | 1.5 | dB         |
|               |                              | $f = 800\text{ MHz}$ ; $Y_S = Y_{S(opt)}$                                     | -     | 1.2 | 1.8 | dB         |
| Xmod          | cross modulation             | input level for $k = 1\%$ ; $f_w = 50\text{ MHz}$ ; $f_{unw} = 60\text{ MHz}$ | [2]   |     |     |            |
|               |                              | at 0 dB AGC                                                                   | 90    | -   | -   | dB $\mu$ V |
|               |                              | at 10 dB AGC                                                                  | -     | 94  | -   | dB $\mu$ V |
|               |                              | at 20 dB AGC                                                                  | -     | 99  | -   | dB $\mu$ V |
|               |                              | at 40 dB AGC                                                                  | 102   | 105 | -   | dB $\mu$ V |

[1] Calculated from S-parameters.

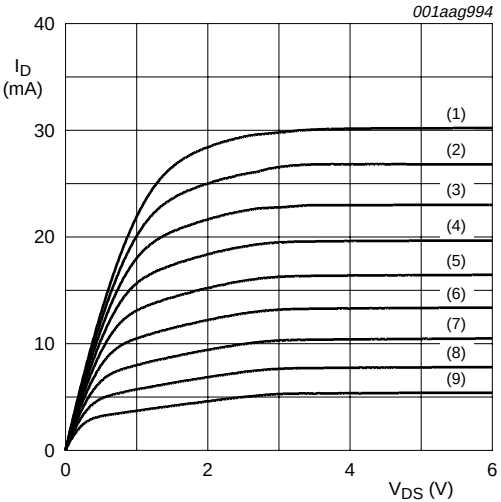
[2] Measured in [Figure 24](#) test circuit.

8.1 Graphs for amplifier A and B



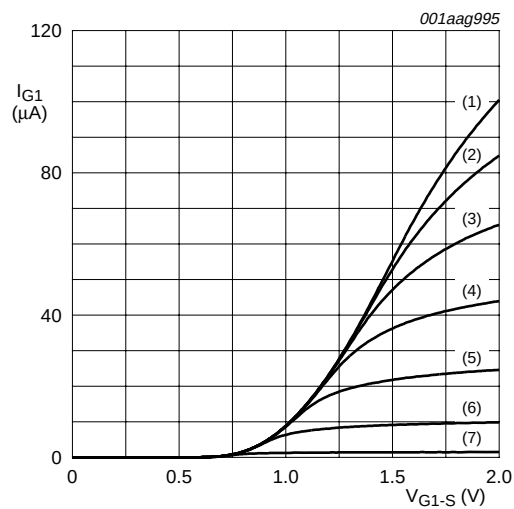
- (1)  $V_{G2-S} = 4.0\text{ V.}$
  - (2)  $V_{G2-S} = 3.5\text{ V.}$
  - (3)  $V_{G2-S} = 3.0\text{ V.}$
  - (4)  $V_{G2-S} = 2.5\text{ V.}$
  - (5)  $V_{G2-S} = 2.0\text{ V.}$
  - (6)  $V_{G2-S} = 1.5\text{ V.}$
  - (7)  $V_{G2-S} = 1.0\text{ V.}$
- $V_{DS} = 5\text{ V; } T_j = 25\text{ }^{\circ}\text{C.}$

Fig 2. Transfer characteristics; typical values



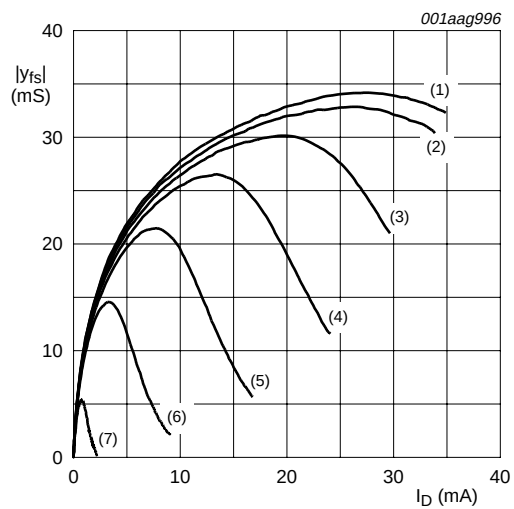
- (1)  $V_{G1-S} = 1.8\text{ V.}$
  - (2)  $V_{G1-S} = 1.7\text{ V.}$
  - (3)  $V_{G1-S} = 1.6\text{ V.}$
  - (4)  $V_{G1-S} = 1.5\text{ V.}$
  - (5)  $V_{G1-S} = 1.4\text{ V.}$
  - (6)  $V_{G1-S} = 1.3\text{ V.}$
  - (7)  $V_{G1-S} = 1.2\text{ V.}$
  - (8)  $V_{G1-S} = 1.1\text{ V.}$
  - (9)  $V_{G1-S} = 1.0\text{ V.}$
- $V_{G2-S} = 4\text{ V; } T_j = 25\text{ }^{\circ}\text{C.}$

Fig 3. Output characteristics; typical values



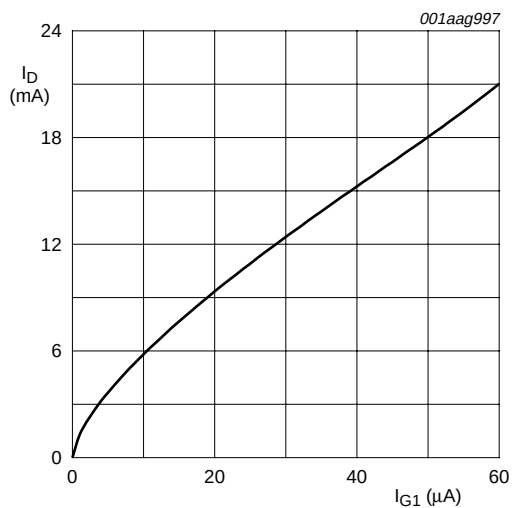
- (1)  $V_{G2-S} = 4.0$  V.
  - (2)  $V_{G2-S} = 3.5$  V.
  - (3)  $V_{G2-S} = 3.0$  V.
  - (4)  $V_{G2-S} = 2.5$  V.
  - (5)  $V_{G2-S} = 2.0$  V.
  - (6)  $V_{G2-S} = 1.5$  V.
  - (7)  $V_{G2-S} = 1.0$  V.
- $V_{DS} = 5$  V;  $T_j = 25$  °C.

Fig 4. Gate1 current as a function of gate1 voltage; typical values



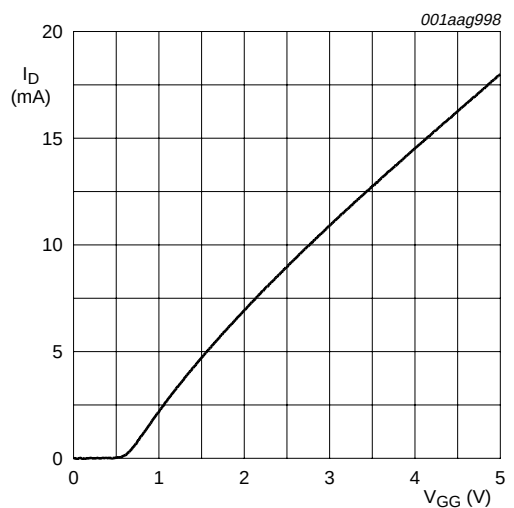
- (1)  $V_{G2-S} = 4.0$  V.
  - (2)  $V_{G2-S} = 3.5$  V.
  - (3)  $V_{G2-S} = 3.0$  V.
  - (4)  $V_{G2-S} = 2.5$  V.
  - (5)  $V_{G2-S} = 2.0$  V.
  - (6)  $V_{G2-S} = 1.5$  V.
  - (7)  $V_{G2-S} = 1.0$  V.
- $V_{DS} = 5$  V;  $T_j = 25$  °C.

Fig 5. Forward transfer admittance as a function of drain current; typical values



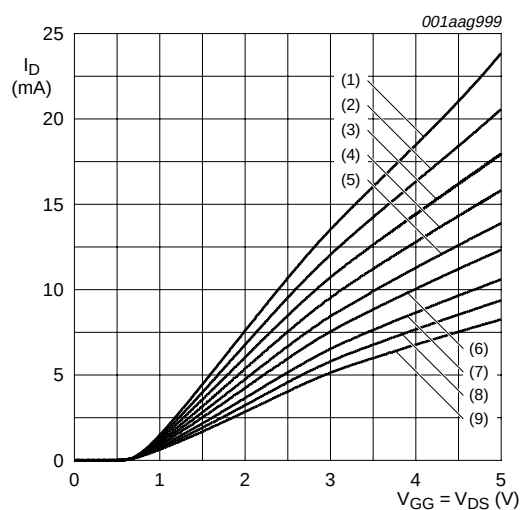
$V_{DS} = 5$  V;  $V_{G2-S} = 4$  V;  $T_j = 25$  °C.

Fig 6. Drain current as a function of gate1 current; typical values



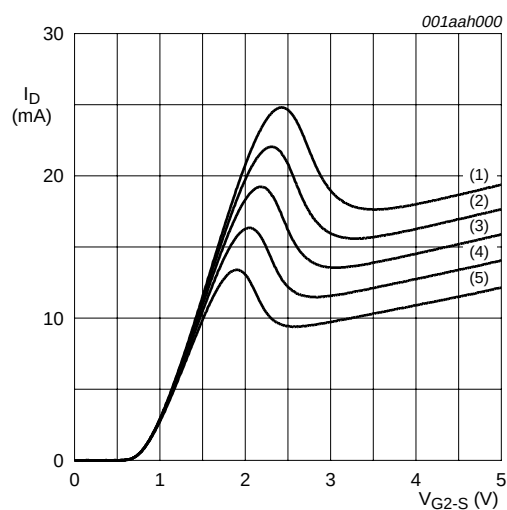
$V_{DS} = 5$  V;  $V_{G2-S} = 4$  V;  $R_{G1} = 68$  k $\Omega$ ;  $T_j = 25$  °C.

Fig 7. Drain current as a function of gate1 supply voltage ( $V_{GG}$ ); typical values



- (1)  $R_{G1} = 47 \text{ k}\Omega$ .
  - (2)  $R_{G1} = 56 \text{ k}\Omega$ .
  - (3)  $R_{G1} = 68 \text{ k}\Omega$ .
  - (4)  $R_{G1} = 82 \text{ k}\Omega$ .
  - (5)  $R_{G1} = 100 \text{ k}\Omega$ .
  - (6)  $R_{G1} = 120 \text{ k}\Omega$ .
  - (7)  $R_{G1} = 150 \text{ k}\Omega$ .
  - (8)  $R_{G1} = 180 \text{ k}\Omega$ .
  - (9)  $R_{G1} = 220 \text{ k}\Omega$ .
- $V_{G2-S} = 4 \text{ V}$ ;  $T_j = 25 \text{ }^\circ\text{C}$ .

**Fig 8.** Drain current as a function of  $V_{DS}$  and  $V_{GG}$ ; typical values

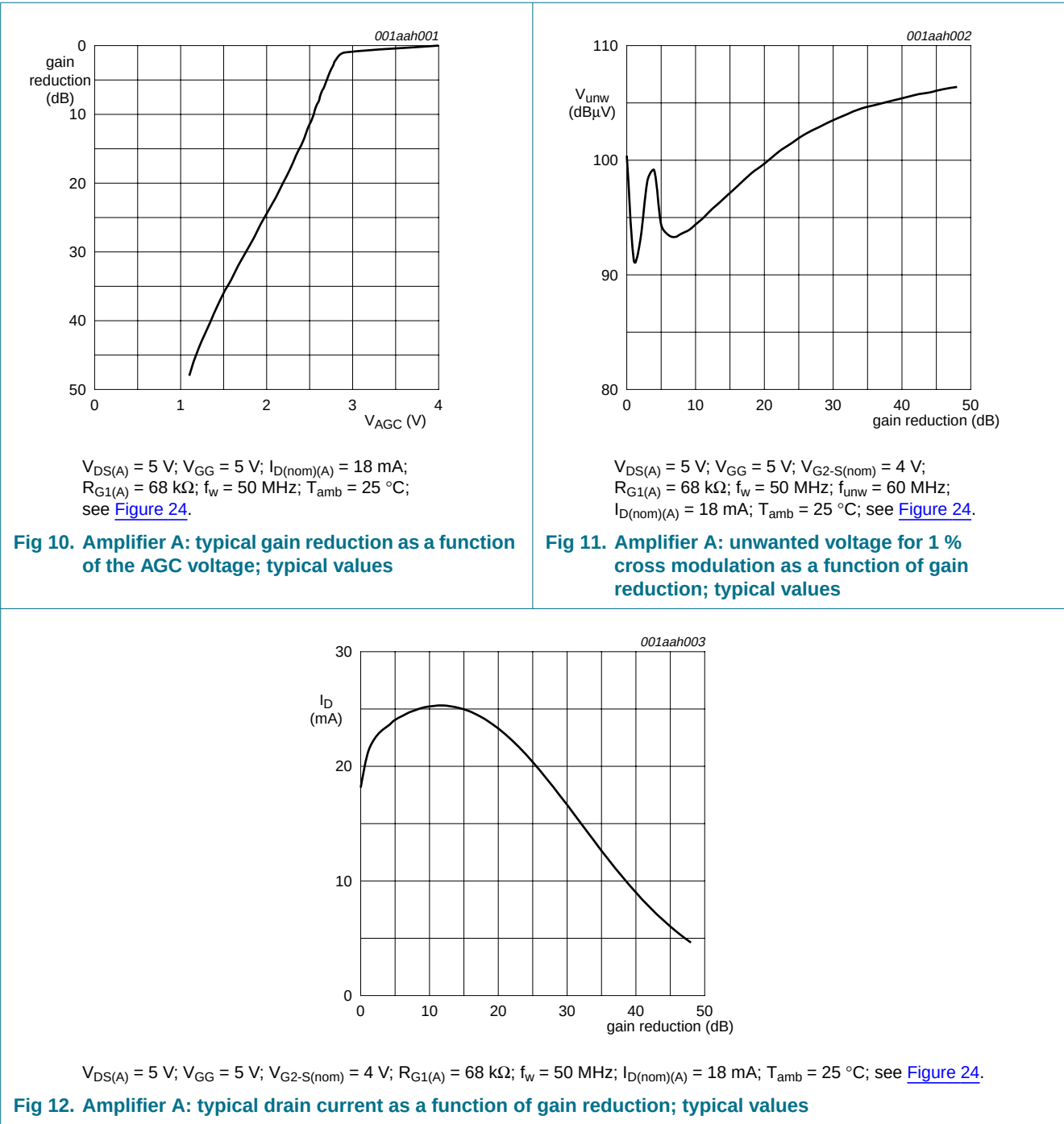


- (1)  $V_{GG} = 5.0 \text{ V}$ .
  - (2)  $V_{GG} = 4.5 \text{ V}$ .
  - (3)  $V_{GG} = 4.0 \text{ V}$ .
  - (4)  $V_{GG} = 3.5 \text{ V}$ .
  - (5)  $V_{GG} = 3.0 \text{ V}$ .
- $T_j = 25 \text{ }^\circ\text{C}$ ;  $R_{G1} = 68 \text{ k}\Omega$  (connected to  $V_{GG}$ ).

**Fig 9.** Drain current as a function of gate2 voltage; typical values



8.2 Graphs for amplifier A



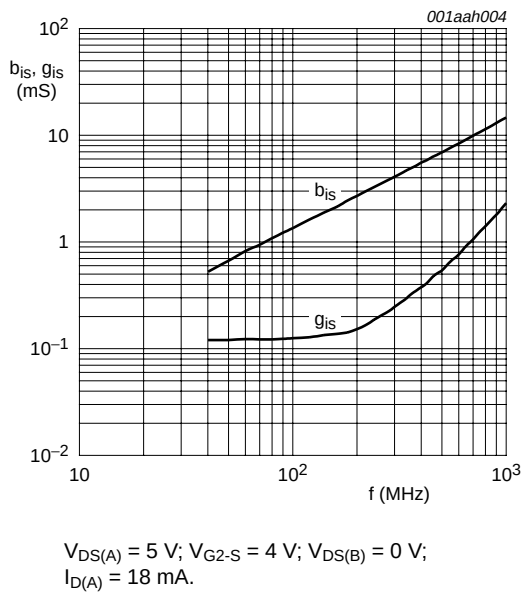


Fig 13. Amplifier A: input admittance as a function of frequency; typical values

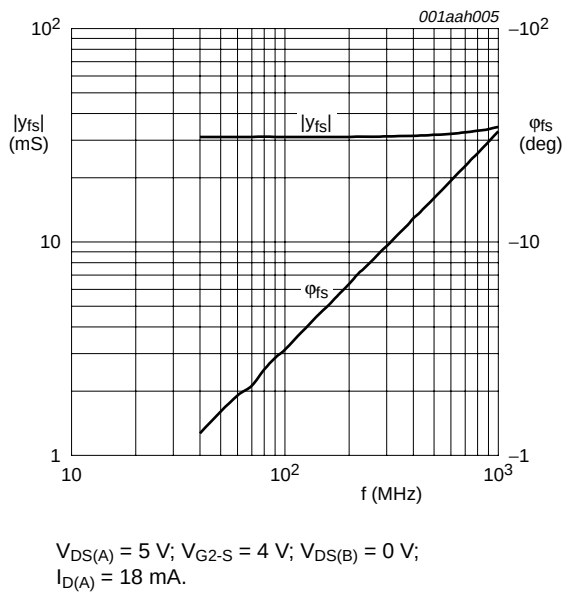


Fig 14. Amplifier A: forward transfer admittance and phase as a function of frequency; typical values

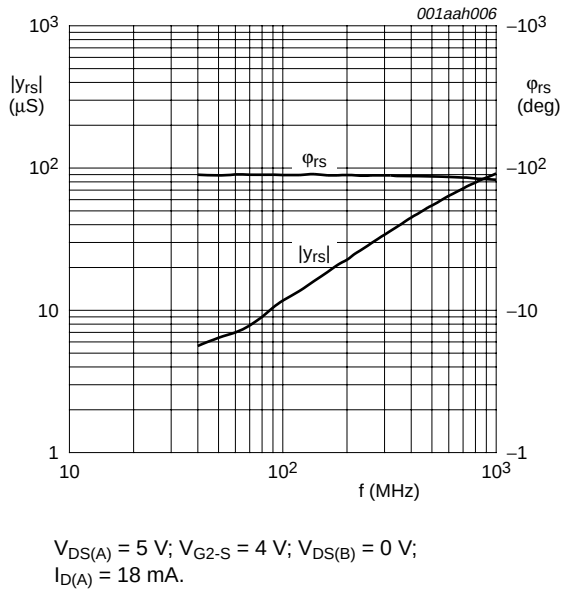


Fig 15. Amplifier A: reverse transfer admittance and phase as a function of frequency; typical values

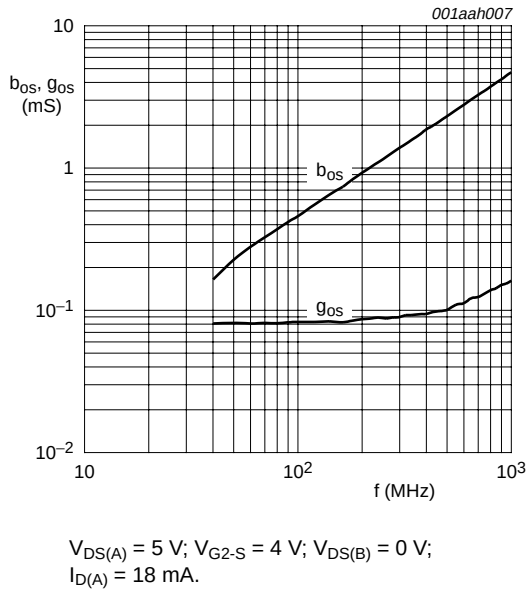


Fig 16. Amplifier A: output admittance as a function of frequency; typical values

### 8.2.1 Scattering parameters for amplifier A

**Table 9. Scattering parameters for amplifier A**

$V_{DS(A)} = 5\text{ V}$ ;  $V_{G2-S} = 4\text{ V}$ ;  $I_{D(A)} = 18\text{ mA}$ ;  $V_{DS(B)} = 0\text{ V}$ ;  $V_{G1-S(B)} = 0\text{ V}$ ;  $T_{amb} = 25\text{ °C}$ ; typical values.

| f (MHz) | S <sub>11</sub>   |             | S <sub>21</sub>   |             | S <sub>12</sub>   |             | S <sub>22</sub>   |             |
|---------|-------------------|-------------|-------------------|-------------|-------------------|-------------|-------------------|-------------|
|         | Magnitude (ratio) | Angle (deg) | Magnitude (ratio) | Angle (deg) | Magnitude (ratio) | Angle (deg) | Magnitude (ratio) | Angle (deg) |
| 40      | 0.9877            | −3.07       | 3.07              | 176.73      | 0.0006            | 88.01       | 0.9902            | −1.00       |
| 100     | 0.9888            | −7.81       | 3.07              | 171.67      | 0.0012            | 85.54       | 0.9918            | −2.74       |
| 200     | 0.9852            | −15.61      | 3.04              | 163.23      | 0.0022            | 80.05       | 0.9910            | −5.50       |
| 300     | 0.9766            | −23.41      | 3.00              | 154.91      | 0.0033            | 75.66       | 0.9896            | −8.22       |
| 400     | 0.9643            | −31.14      | 2.95              | 146.63      | 0.0042            | 71.57       | 0.9881            | −10.93      |
| 500     | 0.9504            | −38.62      | 2.89              | 138.57      | 0.0050            | 67.10       | 0.9859            | −13.61      |
| 600     | 0.9339            | −45.96      | 2.82              | 130.61      | 0.0056            | 63.38       | 0.9836            | −16.28      |
| 700     | 0.9151            | −53.13      | 2.74              | 122.79      | 0.0061            | 59.74       | 0.9813            | −18.96      |
| 800     | 0.8960            | −60.18      | 2.66              | 115.17      | 0.0064            | 56.44       | 0.9790            | −21.60      |
| 900     | 0.8766            | −67.00      | 2.57              | 107.66      | 0.0065            | 53.53       | 0.9769            | −24.20      |
| 1000    | 0.8564            | −73.58      | 2.49              | 100.35      | 0.0066            | 50.29       | 0.9753            | −26.88      |

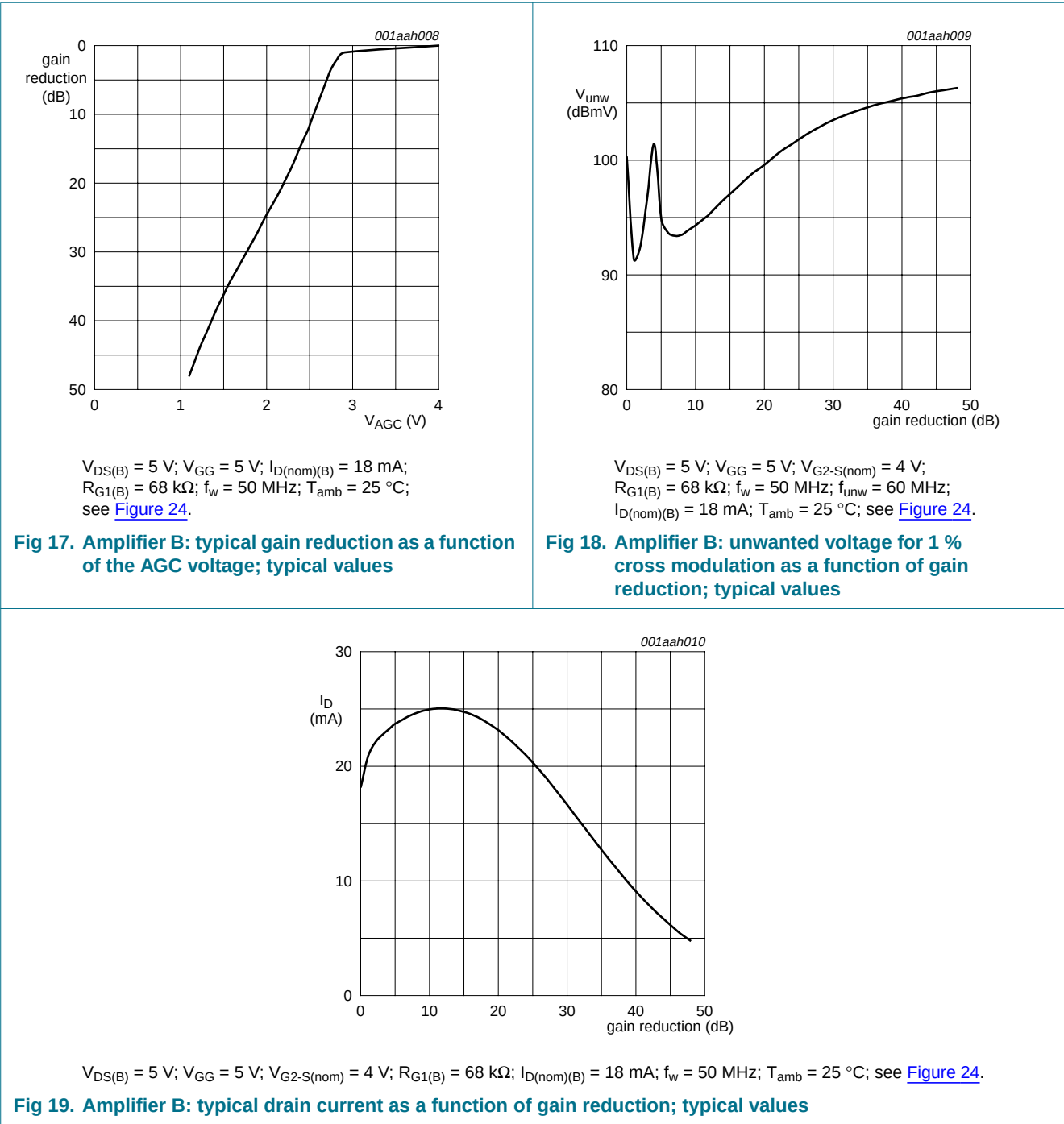
### 8.2.2 Noise data for amplifier A

**Table 10. Noise data for amplifier A**

$V_{DS(A)} = 5\text{ V}$ ;  $V_{G2-S} = 4\text{ V}$ ;  $I_{D(A)} = 18\text{ mA}$ ;  $T_{amb} = 25\text{ °C}$ ; typical values.

| f (MHz) | NF <sub>min</sub> (dB) | Γ <sub>opt</sub> |       | r <sub>n</sub> (ratio) |
|---------|------------------------|------------------|-------|------------------------|
|         |                        | (ratio)          | (deg) |                        |
| 400     | 0.91                   | 0.76             | 23.60 | 0.677                  |
| 800     | 1.23                   | 0.71             | 48.91 | 0.620                  |

8.3 Graphs for amplifier B



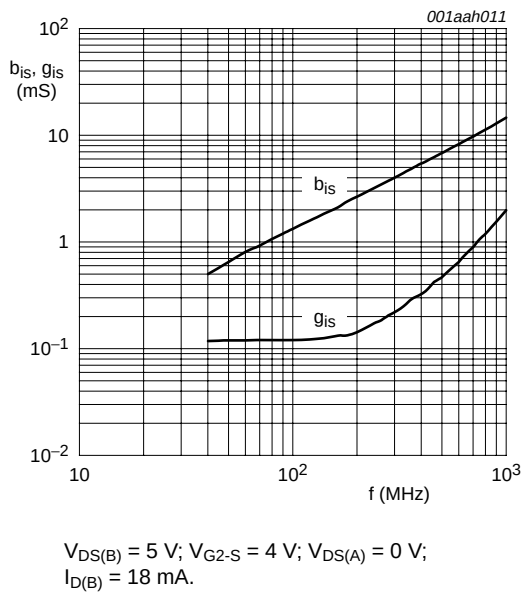


Fig 20. Amplifier B: input admittance as a function of frequency; typical values

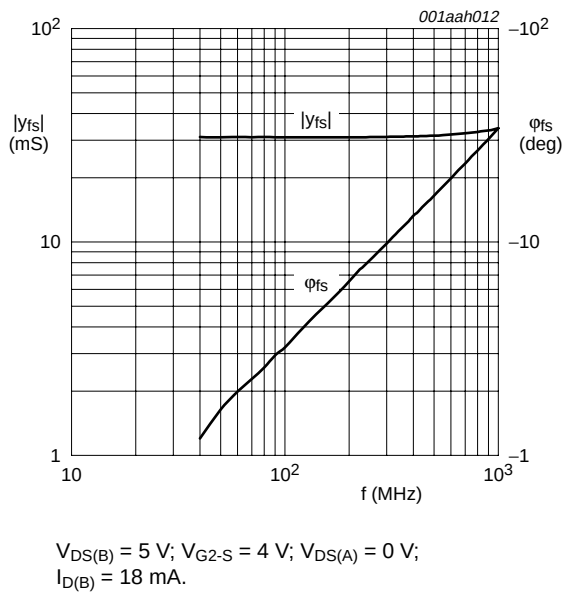


Fig 21. Amplifier B: forward transfer admittance and phase as a function of frequency; typical values

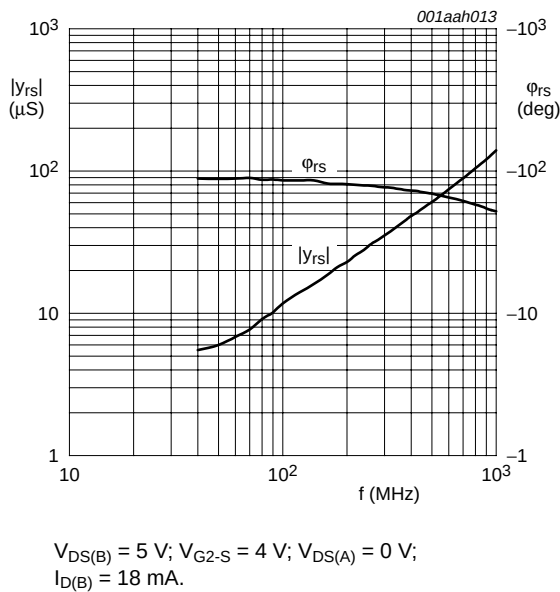


Fig 22. Amplifier B: reverse transfer admittance and phase as a function of frequency; typical values

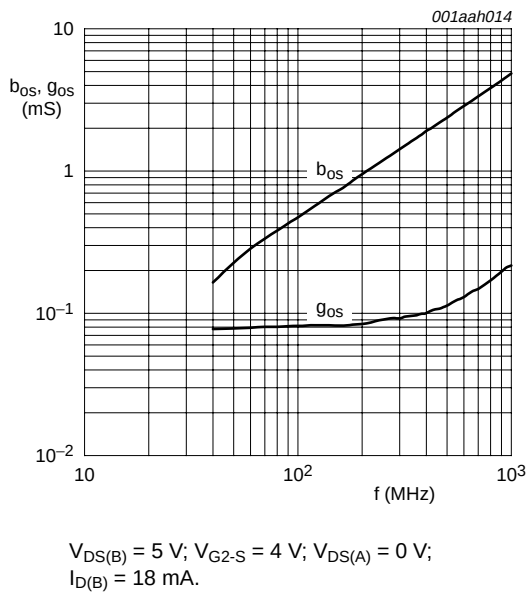


Fig 23. Amplifier B: output admittance as a function of frequency; typical values

8.3.1 Scattering parameters for amplifier B

Table 11. Scattering parameters for amplifier B  
 $V_{DS(B)} = 5\text{ V}$ ;  $V_{G2-S} = 4\text{ V}$ ;  $I_{D(B)} = 18\text{ mA}$ ;  $V_{DS(A)} = 0\text{ V}$ ;  $V_{G1-S(A)} = 0\text{ V}$ ;  $T_{amb} = 25\text{ }^{\circ}\text{C}$ ; typical values.

| f (MHz) | S11               |             | S21               |             | S12               |             | S22               |             |
|---------|-------------------|-------------|-------------------|-------------|-------------------|-------------|-------------------|-------------|
|         | Magnitude (ratio) | Angle (deg) | Magnitude (ratio) | Angle (deg) | Magnitude (ratio) | Angle (deg) | Magnitude (ratio) | Angle (deg) |
| 40      | 0.9836            | -2.92       | 3.06              | 176.89      | 0.0005            | 89.71       | 0.9897            | -0.98       |
| 100     | 0.9890            | -7.68       | 3.06              | 171.63      | 0.0012            | 92.19       | 0.9920            | -2.79       |
| 200     | 0.9869            | -15.32      | 3.03              | 163.14      | 0.0023            | 88.94       | 0.9914            | -5.62       |
| 300     | 0.9801            | -23.00      | 2.99              | 154.74      | 0.0034            | 87.64       | 0.9902            | -8.42       |
| 400     | 0.9704            | -30.69      | 2.94              | 146.34      | 0.0045            | 86.52       | 0.9889            | -11.21      |
| 500     | 0.9595            | -38.13      | 2.88              | 138.13      | 0.0056            | 85.29       | 0.9869            | -14.01      |
| 600     | 0.9458            | -45.45      | 2.81              | 129.99      | 0.0066            | 84.60       | 0.9845            | -16.81      |
| 700     | 0.9300            | -52.67      | 2.73              | 121.93      | 0.0075            | 83.78       | 0.9818            | -19.64      |
| 800     | 0.9132            | -59.82      | 2.65              | 114.01      | 0.0085            | 82.86       | 0.9786            | -22.44      |
| 900     | 0.8959            | -66.74      | 2.56              | 106.18      | 0.0093            | 81.97       | 0.9750            | -25.22      |
| 1000    | 0.8775            | -73.43      | 2.47              | 98.51       | 0.0101            | 80.62       | 0.9717            | -28.10      |

8.3.2 Noise data for amplifier B

Table 12. Noise data for amplifier B  
 $V_{DS(B)} = 5\text{ V}$ ;  $V_{G2-S} = 4\text{ V}$ ;  $I_{D(B)} = 18\text{ mA}$ ;  $T_{amb} = 25\text{ }^{\circ}\text{C}$ ; typical values.

| f (MHz) | NF <sub>min</sub> (dB) | $\Gamma_{opt}$ |       | r <sub>n</sub> (ratio) |
|---------|------------------------|----------------|-------|------------------------|
|         |                        | (ratio)        | (deg) |                        |
| 400     | 0.91                   | 0.76           | 22.58 | 0.690                  |
| 800     | 1.24                   | 0.71           | 47.34 | 0.620                  |

9. Test information

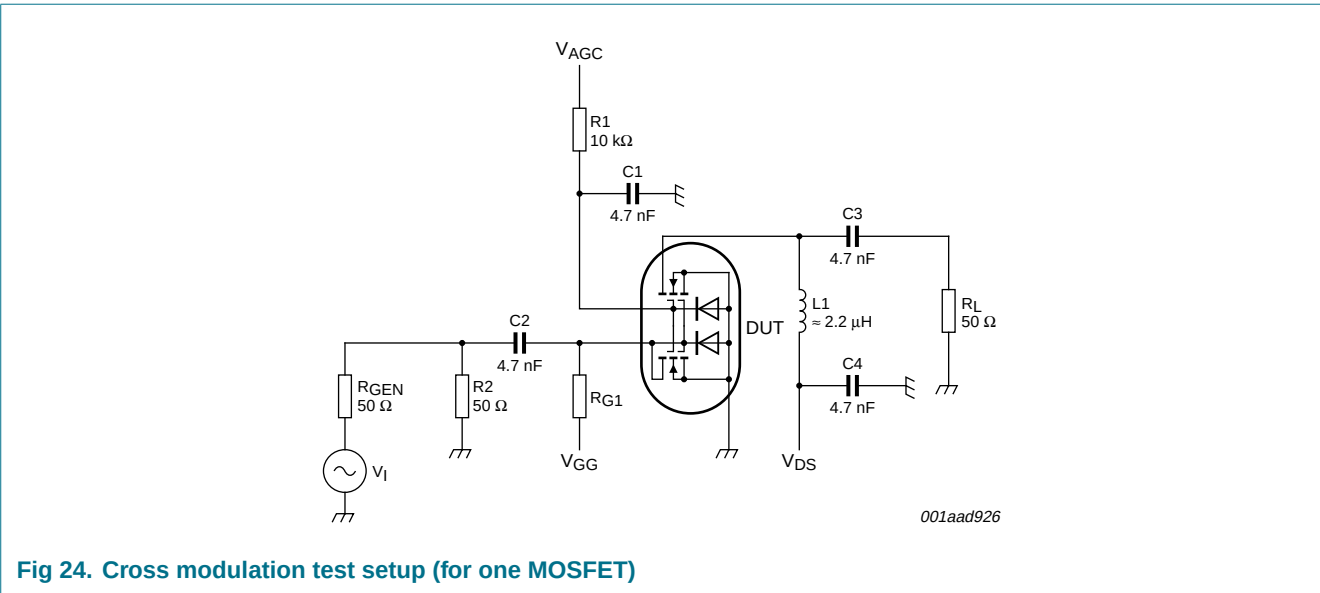


Fig 24. Cross modulation test setup (for one MOSFET)

10. Package outline

Plastic surface-mounted package; 6 leads

SOT363

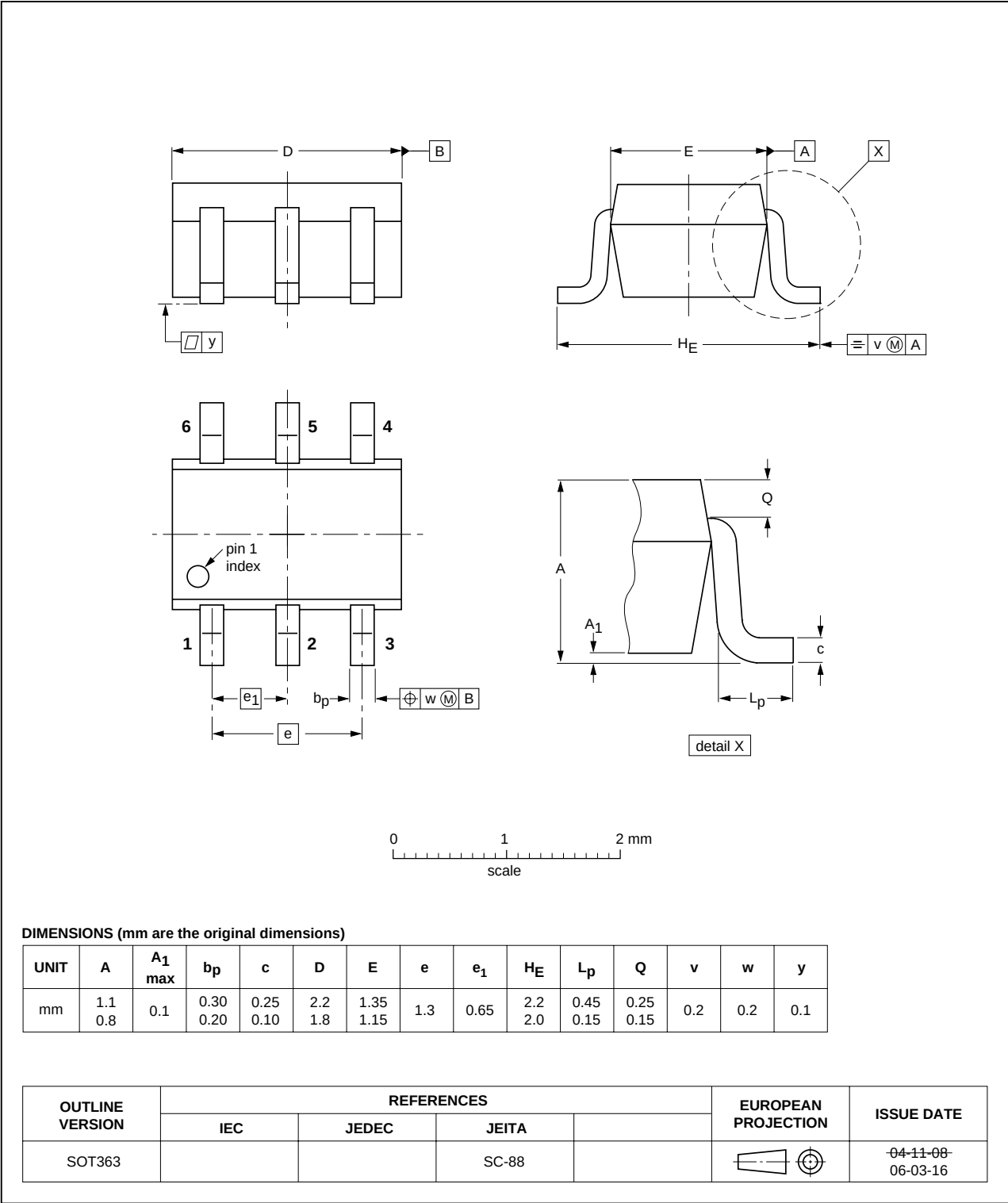


Fig 25. Package outline SOT363

## 11. Abbreviations

Table 13. Abbreviations

| Acronym | Description                                       |
|---------|---------------------------------------------------|
| AGC     | Automatic Gain Control                            |
| DC      | Direct Current                                    |
| MOSFET  | Metal-Oxide-Semiconductor Field-Effect Transistor |
| UHF     | Ultra High Frequency                              |
| VHF     | Very High Frequency                               |

## 12. Revision history

Table 14. Revision history

| Document ID | Release date | Data sheet status  | Change notice | Supersedes |
|-------------|--------------|--------------------|---------------|------------|
| BF1214_1    | 20071030     | Product data sheet | -             | -          |



## 13. Legal information

### 13.1 Data sheet status

| Document status <sup>[1][2]</sup> | Product status <sup>[3]</sup> | Definition                                                                            |
|-----------------------------------|-------------------------------|---------------------------------------------------------------------------------------|
| Objective [short] data sheet      | Development                   | This document contains data from the objective specification for product development. |
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| Product [short] data sheet        | Production                    | This document contains the product specification.                                     |

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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